

ECE4904 Lecture 5

Energy Band Diagram Review

E_F flat in equilibrium

pn Junction

Doping profile (5.1.1)

Step junction approximation

pn Junction: Handwaving

Qualitative Electrostatics (5.1.2, 3)

Built-in Potential (5.1.4)

Depletion Approximation (5.1.5)

Quantitative Electrostatics (5.2)

Qualitative forward, reverse bias (5.2.4)

Hand In: HW 2

Handouts

HW Set 2 problem 3.12

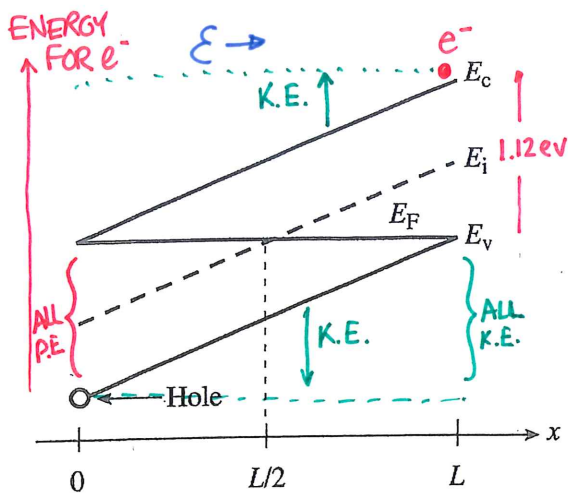
Text Figure 5.1: Doping Profile

pn Junction: Handwaving

pn junction: Electrostatics

Depletion region equations

Forward-Zero-Reverse bias



3.12 Interpretation of Energy Band Diagrams

Six different silicon samples maintained at 300 K are characterized by the energy band diagrams in Fig. P3.12. Answer the questions that follow after choosing a specific diagram for analysis. Possibly repeat using other energy band diagrams. (Excessive repetitions have been known to lead to the onset of insanity.)

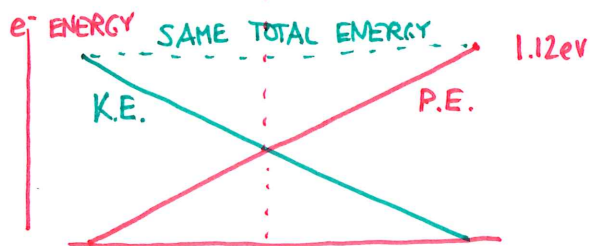
- Do equilibrium conditions prevail? How do you know? **YES: E_F FLAT**
- Sketch the electrostatic potential (V) inside the semiconductor as a function of x . **$V \propto \frac{1}{\omega_i}$**
- Sketch the electric field (\mathcal{E}) inside the semiconductor as a function of x .
- The carrier pictured on the diagram moves back and forth between $x = 0$ and $x = L$ without changing its total energy. Sketch the K.E. and P.E. of the carrier as a function of position inside the semiconductor. Let E_F be the energy reference level.
- Roughly sketch n and p versus x .
- On the same set of coordinates, make a rough sketch of the electron drift-current density ($J_{N\text{drift}}$) and the electron diffusion-current density ($J_{N\text{diff}}$) inside the Si sample as a function of position. Be sure to graph the proper polarity of the current densities at all points and clearly identify your two current components. Also briefly explain how you arrived at your sketch.

**V: E_F AS 0V REFERENCE, E_i FOR V
 E_v UPSIDE DOWN (e^- IS NEG. CHARGE)**

$$\mathcal{E} = -\frac{dV}{dx}$$

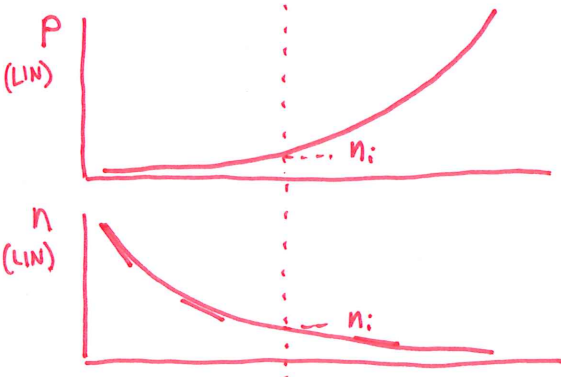
$\mathcal{E} \rightarrow$

CONSTANT POSITIVE POINTING IN $+x$ DIRECTION



$$n = n_i e^{(E_F - E_i)/kT}$$

$$p = n_i e^{(E_i - E_F)/kT}$$

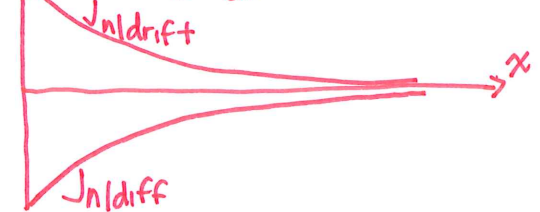


e^- DIFFUSION

e^- DRIFT

e^- MOTION \Rightarrow $J_{N\text{diff}}$ \leftarrow $qD_n \frac{dn}{dx}$

$\mathcal{E} \rightarrow$ e^- MOTION \Rightarrow $J_{N\text{drift}}$ \leftarrow $qn\mu\mathcal{E}$

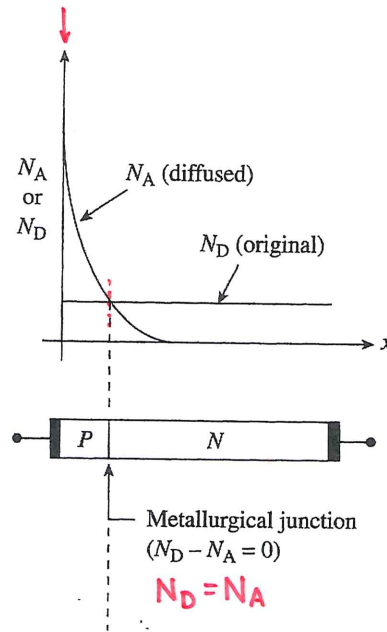


$J_{N\text{drift}} = -J_{N\text{diff}}$ EVERYWHERE!

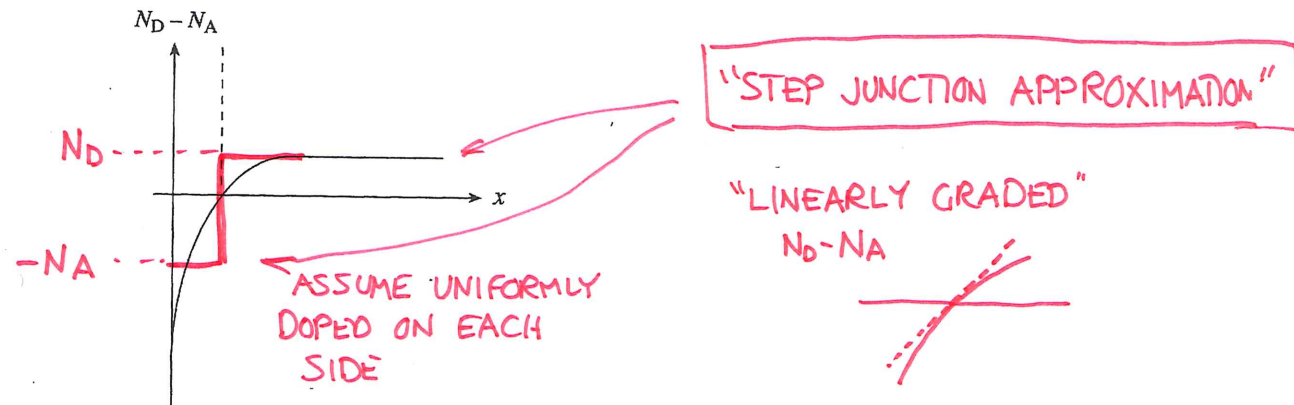
$J_{N\text{TOTAL}} = 0$ EVERYWHERE!

EQUILIBRIUM!

SURFACE OF Si WAFER



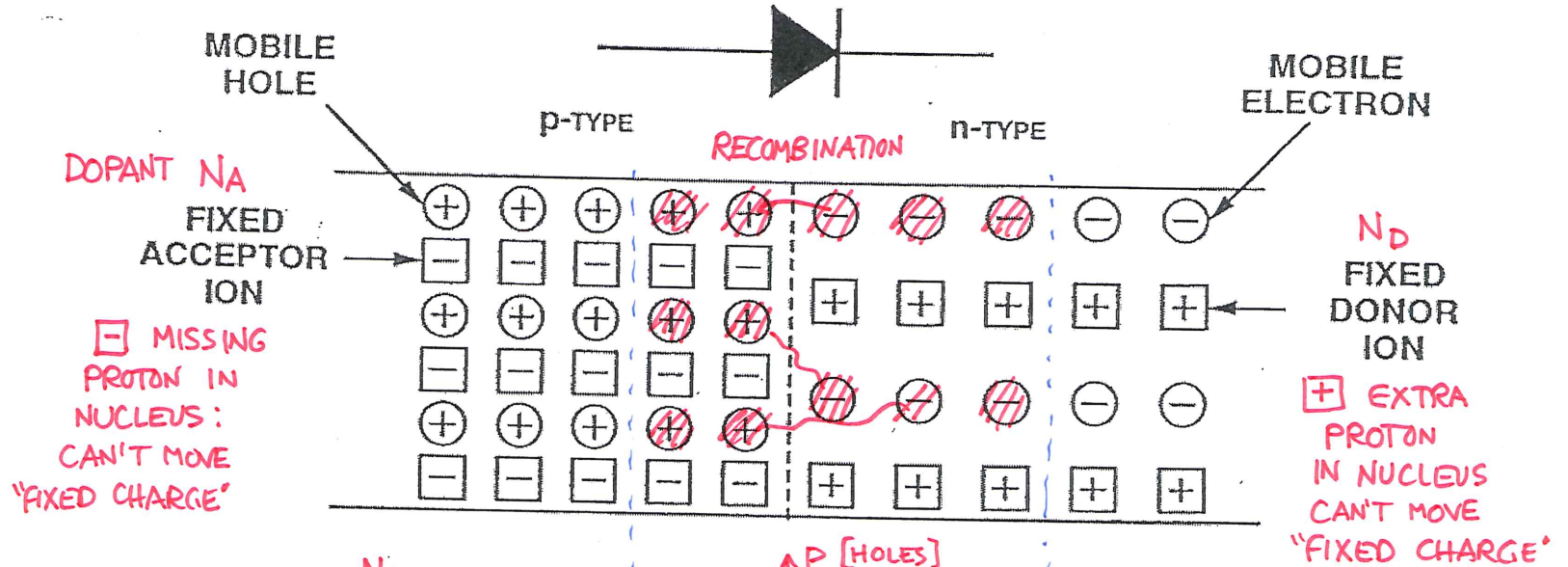
(a)

"DOPING PROFILE" PLOT OF $N_D - N_A$ VS. x 

(b)

Figure 5.1 Junction definitions: (a) Location of the metallurgical junction, (b) doping profile—a plot of the net doping versus position.

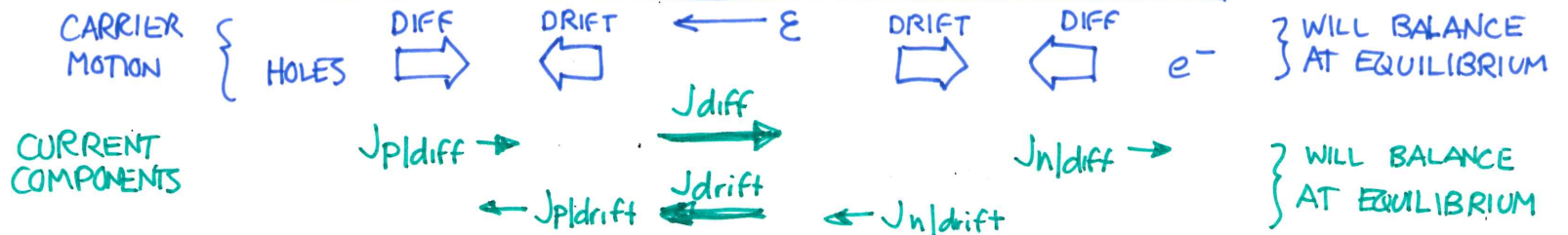
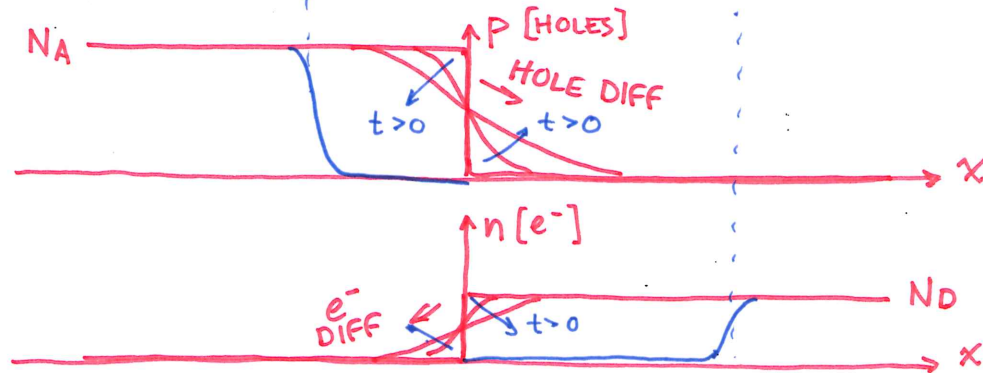
EVERYTHING ELECTRICALLY NEUTRAL

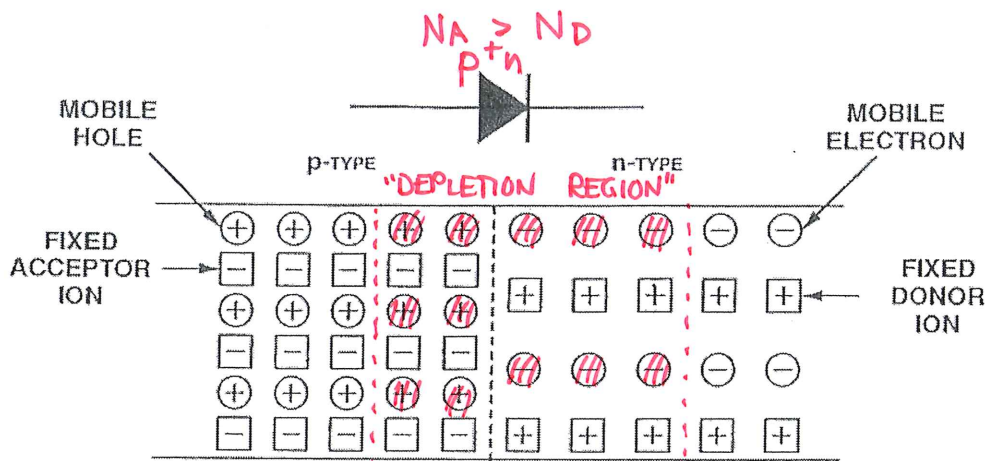


INITIALLY: $E = 0$
EVERYWHERE
NO DRIFT

CARRIERS
WILL MOVE
DUE TO DIFFUSION
 e^- -HOLE PAIR
RECOMBINATION

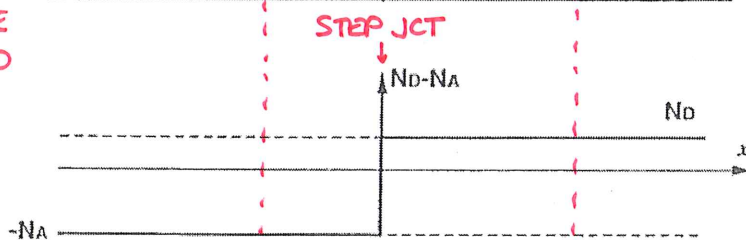
MOBILE
CARRIER
CONCENTRATIONS:



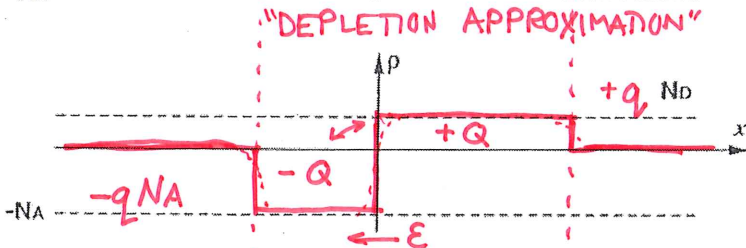


p SIDE MORE HEAVILY DOPED

DOPING PROFILE



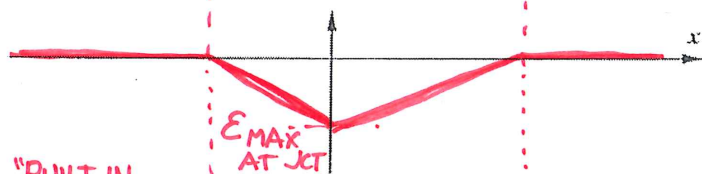
TOTAL & BALANCE CHARGE DENSITY
ZERO OUTSIDE DEPL REGION



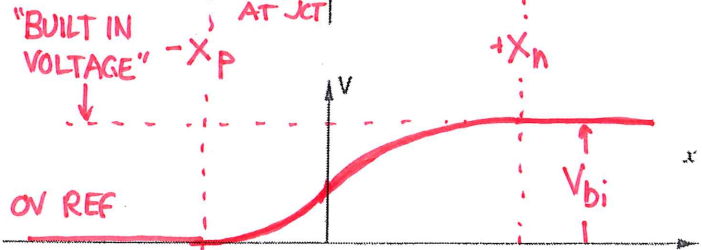
POISSON'S EQUATION

$$\frac{dE}{dx} = \frac{\rho}{K_s \epsilon_0}$$

$E=0$ OUTSIDE DEPL REGION
ELECTRIC FIELD



EXTENT OF DEPL REGION INTO EACH SIDE



FIELD DEFINITION

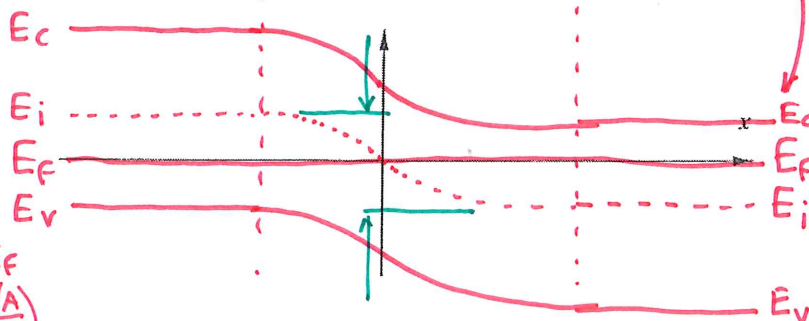
$$E = -\frac{dV}{dx}$$

$$V = -\int E dx + C$$

CHOOSE OV REFERENCE

ZERO BIAS
 $I=0$ EQUILIBRIUM

ENERGY BAND DIAGRAM



$V \rightarrow E_i, E_c, E_v$ "UPSIDE DOWN"

$$V_{bi} = \frac{kT}{q} \ln \left(\frac{N_A N_D}{n_i^2} \right)$$

n-TYPE $E_f > E_i$

$$E_f - E_i = kT \ln \left(\frac{N_D}{n_i} \right)$$

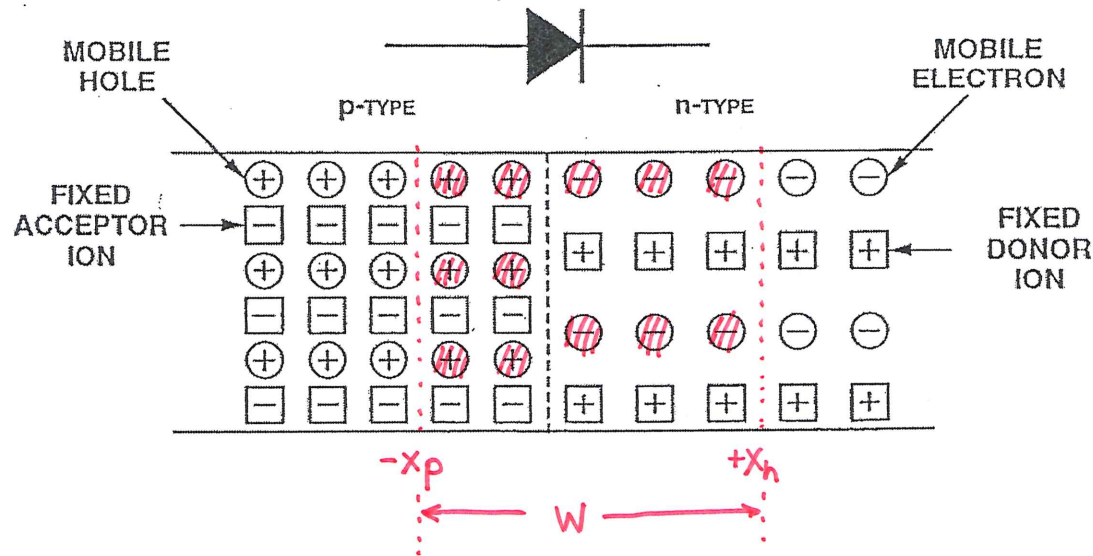
p-TYPE $E_i > E_f$
 $E_i - E_f = kT \ln \left(\frac{N_A}{n_i} \right)$

$$kT \ln \left(\frac{N_A}{n_i} \right) + kT \ln \left(\frac{N_D}{n_i} \right)$$

$$kT \ln \left(\frac{N_A N_D}{n_i^2} \right)$$

AFTER MUCH MATH (SEE CH. 5)

$$V_{bi} = \frac{kT}{q} \ln \left(\frac{N_A N_D}{n_i^2} \right)$$



APPROX: $N_A \gg N_D$

$$x_p = \sqrt{\frac{2K_s \epsilon_0}{q} \frac{N_D}{N_A} \frac{1}{N_A + N_D} V_{bi}}$$

$$x_p \approx \sqrt{\frac{2K_s \epsilon_0}{q} \frac{N_D}{N_A^2} V_{bi}}$$

$$x_n = \sqrt{\frac{2K_s \epsilon_0}{q} \frac{N_A}{N_D} \frac{1}{N_A + N_D} V_{bi}}$$

$$x_n \approx \sqrt{\frac{2K_s \epsilon_0}{q} \frac{1}{N_D} V_{bi}}$$

SAME!

$$W = \sqrt{\frac{2K_s \epsilon_0}{q} \left(\frac{N_A + N_D}{N_A N_D} \right) V_{bi}}$$

$$W \approx \sqrt{\frac{2K_s \epsilon_0}{q} \frac{1}{N_D} V_{bi}}$$

DEPLETION REGION EXISTS MOSTLY IN LIGHTLY DOPED SIDE!

W DEPENDS ONLY ON "LIGHTLY DOPED SIDE" DOPING

EXAMPLE:

$$\left. \begin{array}{l} N_A = 1E+17 / \text{cm}^3 \\ N_D = 1E+14 / \text{cm}^3 \end{array} \right\} N_A \gg N_D$$

@ T = 300K

$$V_{bi} = \frac{kT}{q} \ln \left(\frac{N_A N_D}{n_i^2} \right)$$

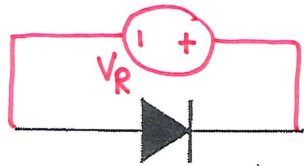
$$\approx 25.9 \text{ mV} \ln \left(\frac{1E+31}{1E+20} \right)$$

$$V_{bi} = 0.659 \text{ V}$$

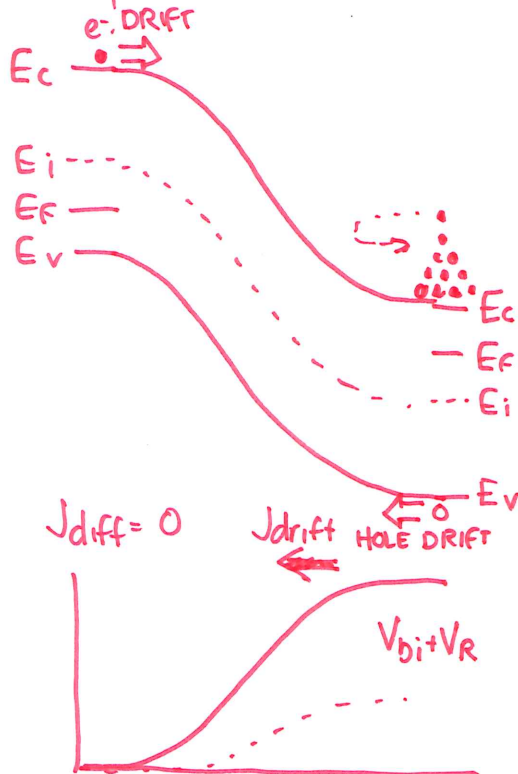
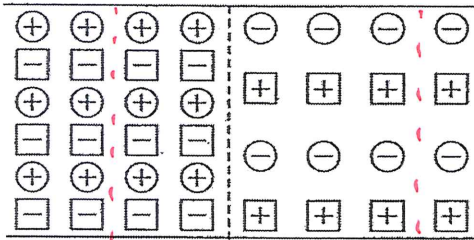
$$x_n = 2.93 E-4 \text{ cm} = 2.93 \mu\text{m}$$

$$x_p = 2.93 E-7 \text{ cm} = 2.93 \text{ nm}$$

NON EQUILIBRIUM
REVERSE BIAS ADDS
TO V_{bi}



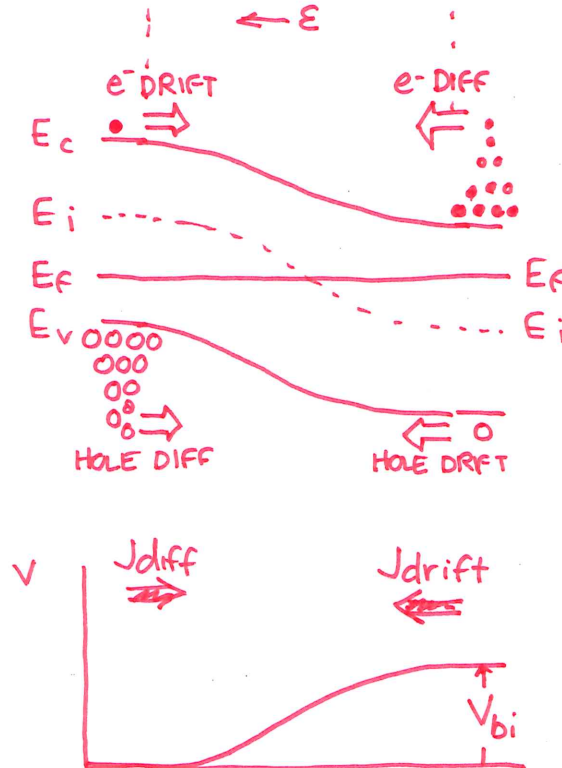
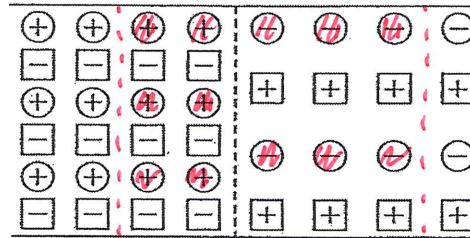
p-TYPE n-TYPE



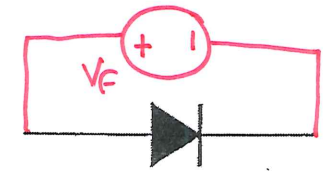
ZERO BIAS
 $V_A = 0$ } EQUILIB



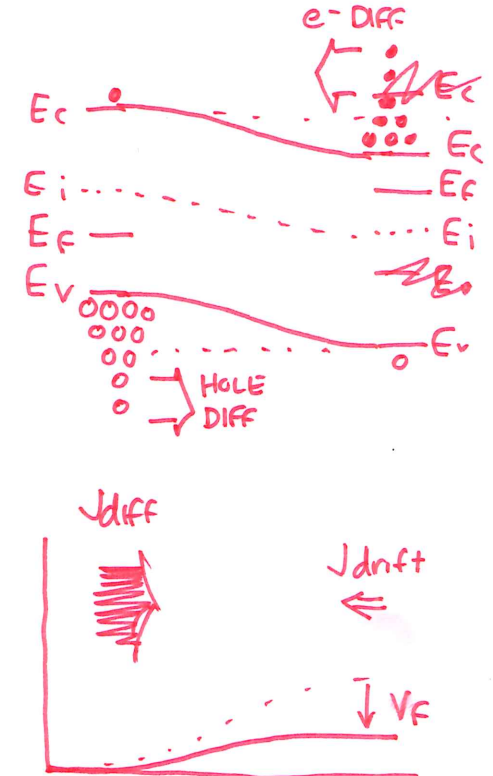
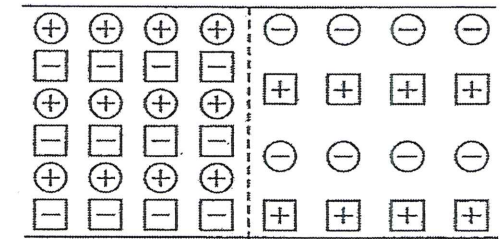
p-TYPE n-TYPE



NON EQUILIBRIUM
FORWARD BIAS



p-TYPE n-TYPE



DIFFUSION